Application/Control No. Applicant(s)/Patent Under Reexamination 10/527,155 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Mark A. Chapman 1756 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-5,915,150 06-1999 Kukimoto et al. 399/149 US-В US-С US-D US-Ε US-F US-G US-Н USı J US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Country Name Classification MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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